

Notice of References Cited

Application/Control No.

09/980,814

Applicant(s)/Patent Under
Reexamination
FUKUI ET AL.

Examiner

XIAO M. WU

Art Unit

2674

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,581,280	04-1986	Taguchi et al.	428/212
	B	US-4,710,433	12-1987	Rowe et al.	428/623
	C	US-5,925,438	07-1999	Ota et al.	428/141
	D	US-5,993,898	11-1999	Nagatsuka, Jun	427/162
	E	US-6,329,044	12-2001	Inoue et al.	428/209
	F	US-6,337,771	01-2002	Chu et al.	359/586
	G	US-6,352,761	03-2002	Hebrink et al.	428/212
	H	US-6,590,622	07-2003	Nakanishi et al.	349/12
	I	US-6,629,833	10-2003	Ohya et al.	425/458
	J	US-6,657,271	12-2003	Katsuragawa, Jun	257/437
	K	US-6,727,566	04-2004	Fukui et al.	257/437
	L	US-2002/0197824	12-2002	Katsuragawa, Jun	438/437
	M	US-2004/0017363	01-2004	Nakanishi et al.	345/173

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.